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Inter-University Research Institute Corporation /
Research Organization of Information and Systems
National Institute of Informatics

Supervised Pattern Mining

Data Mining 04 (データマイニング)

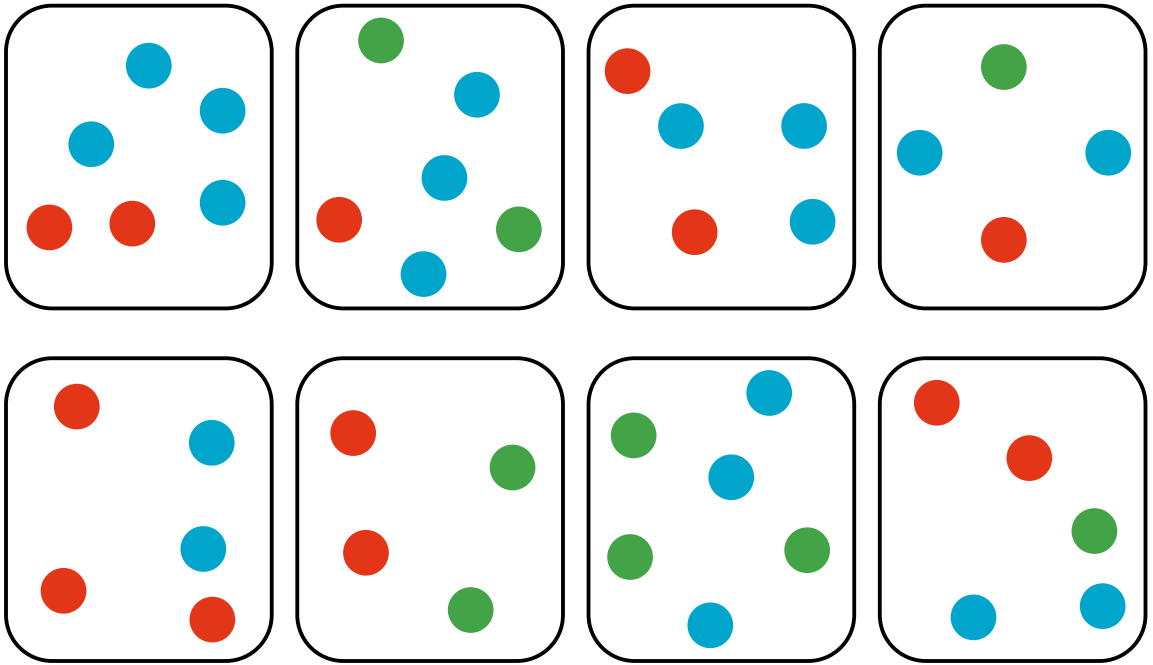
Mahito Sugiyama (杉山麿人)

Today's Outline

- Pattern mining with class labels (supervision)
  - Various measures
- Significant pattern mining
  - Statistical tests
  - Testable patterns
  - Controlling the FWER (Family-Wise Error Rate) by Tarone's testability trick

Itemset Mining

- Find interesting combinatorial patterns from massive data



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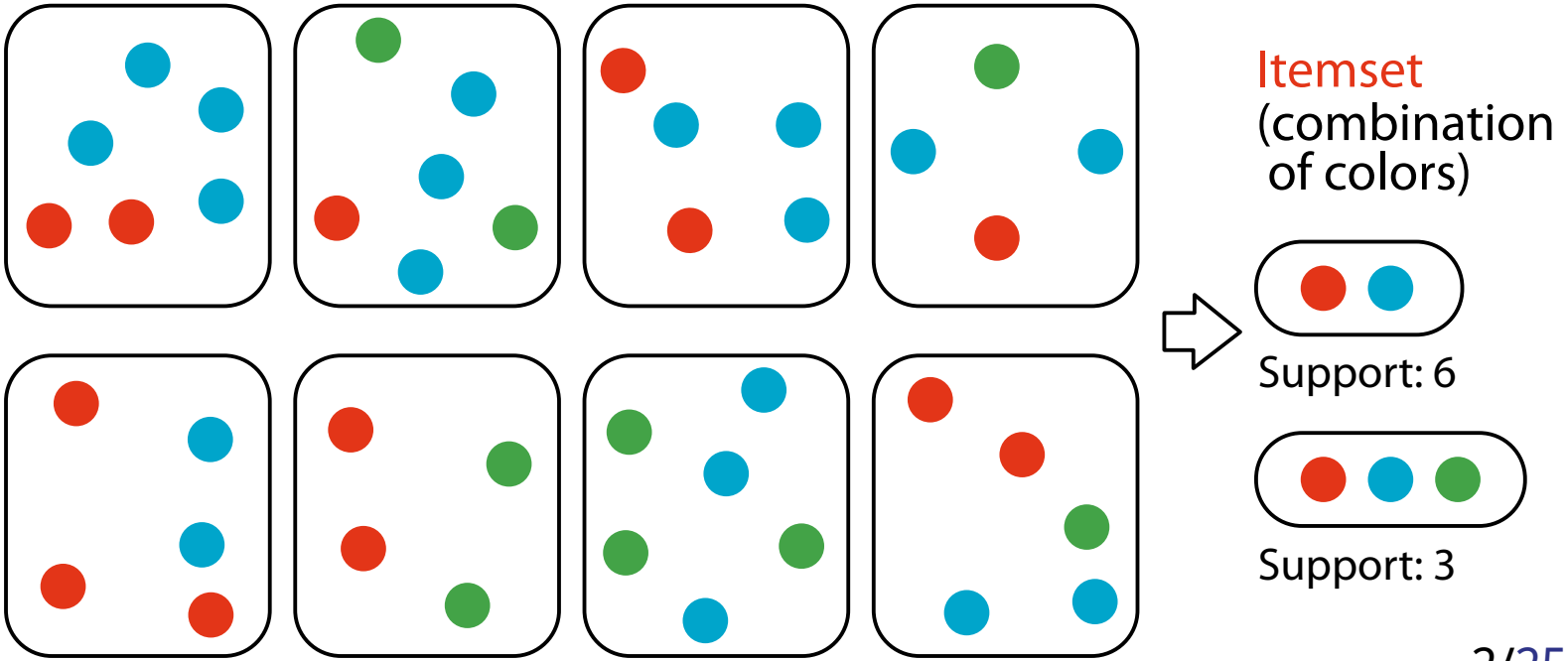
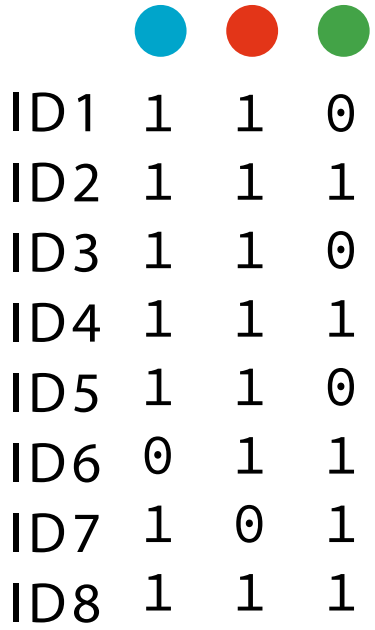
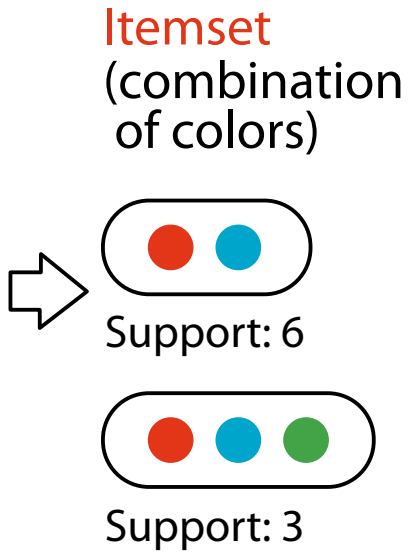


Itemset Mining (Binary Representation)

- Find interesting combinatorial patterns from massive data



ID1	1	1	0
ID2	1	1	1
ID3	1	1	0
ID4	1	1	1
ID5	1	1	0
ID6	0	1	1
ID7	1	0	1
ID8	1	1	1



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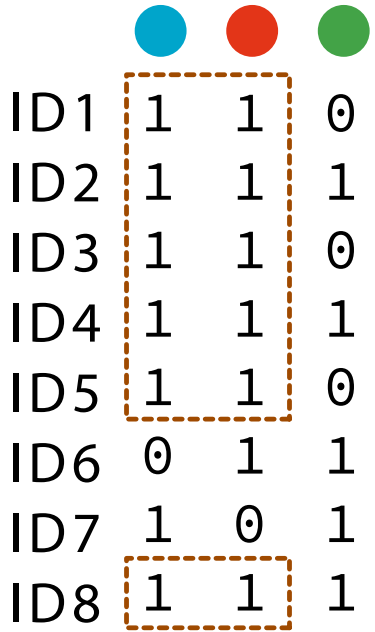
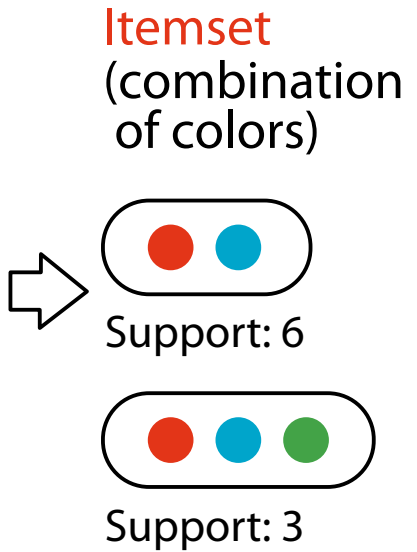
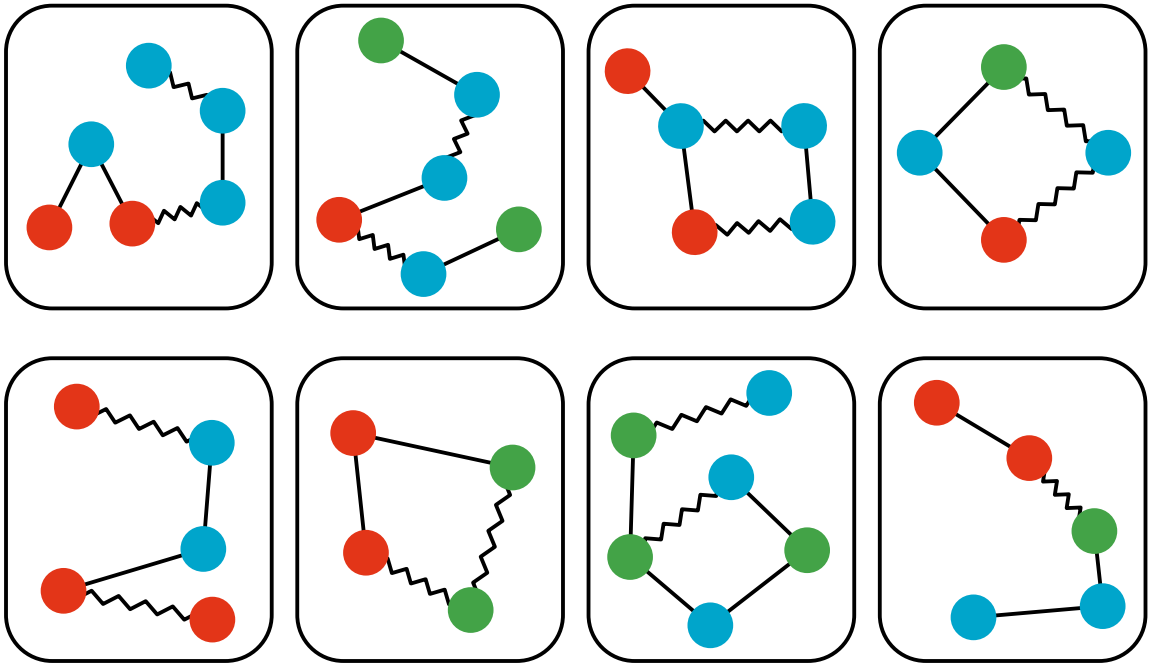




Subgraph Mining

- Find interesting combinatorial patterns from massive data



Subgraph Mining

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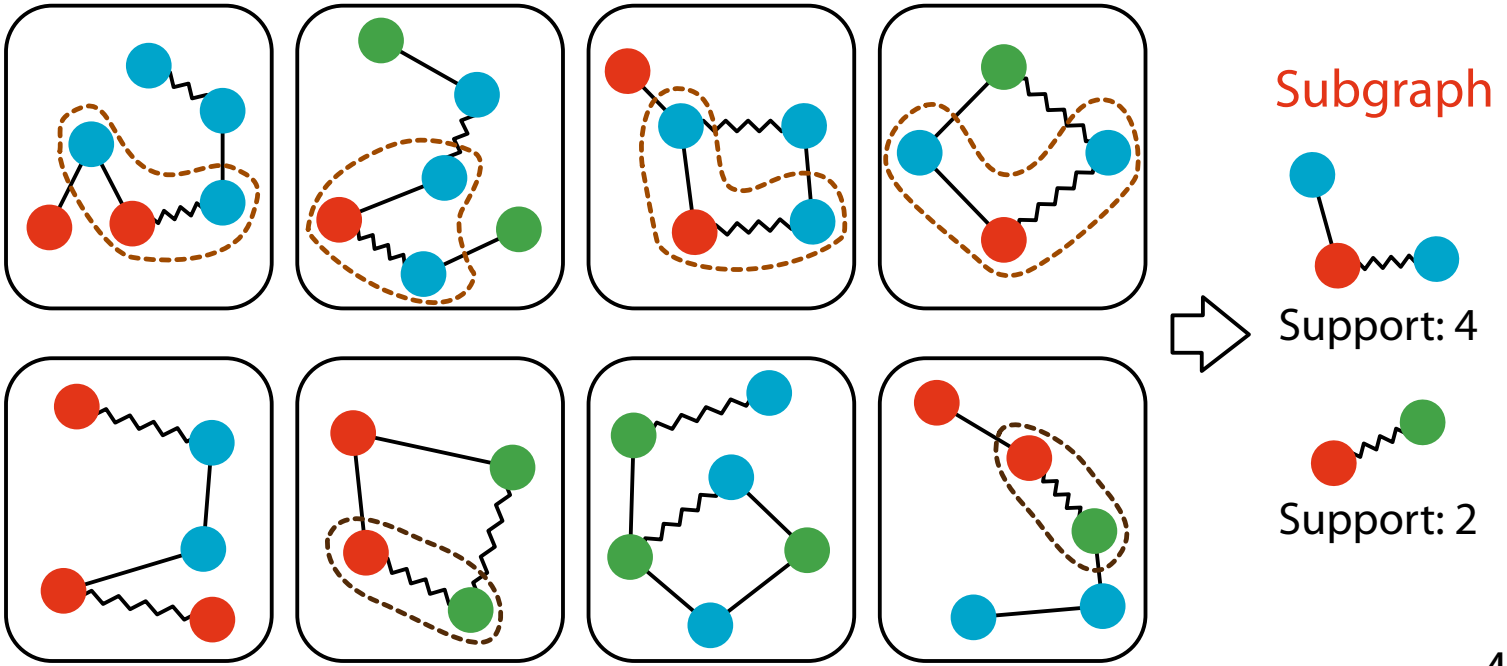
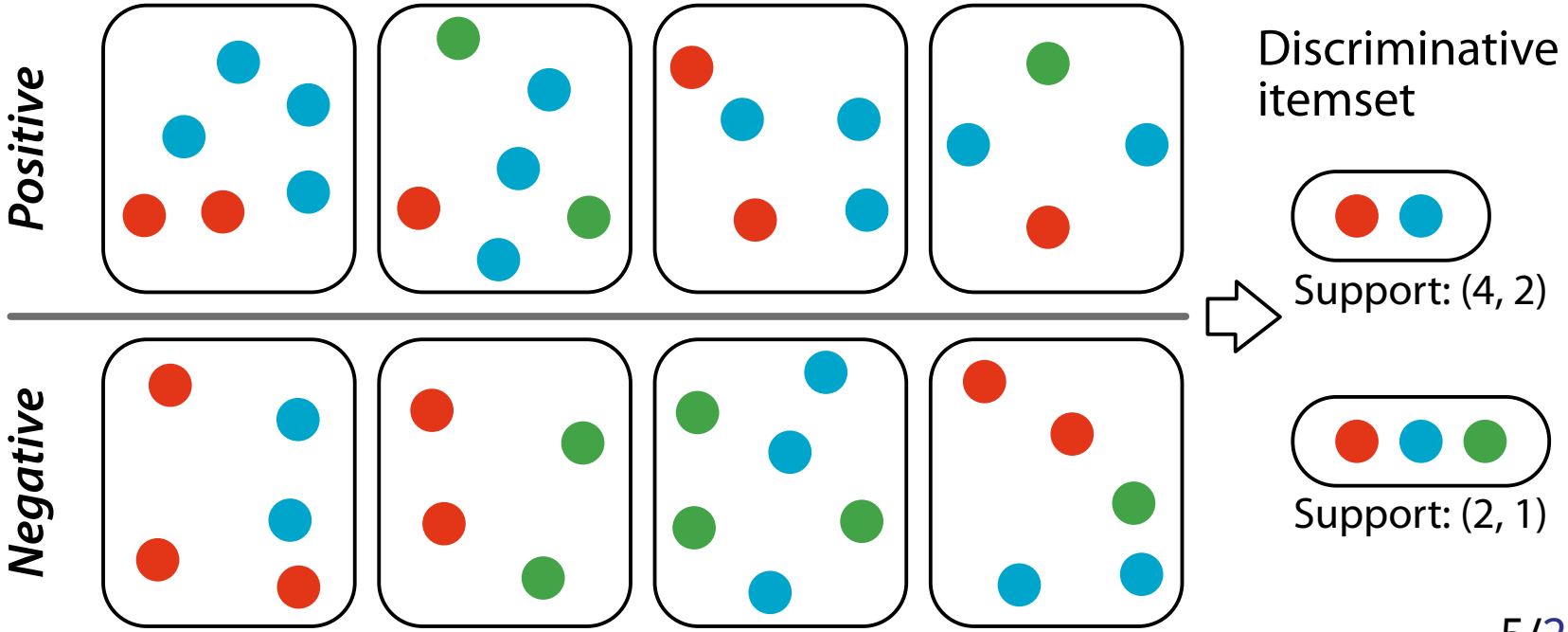


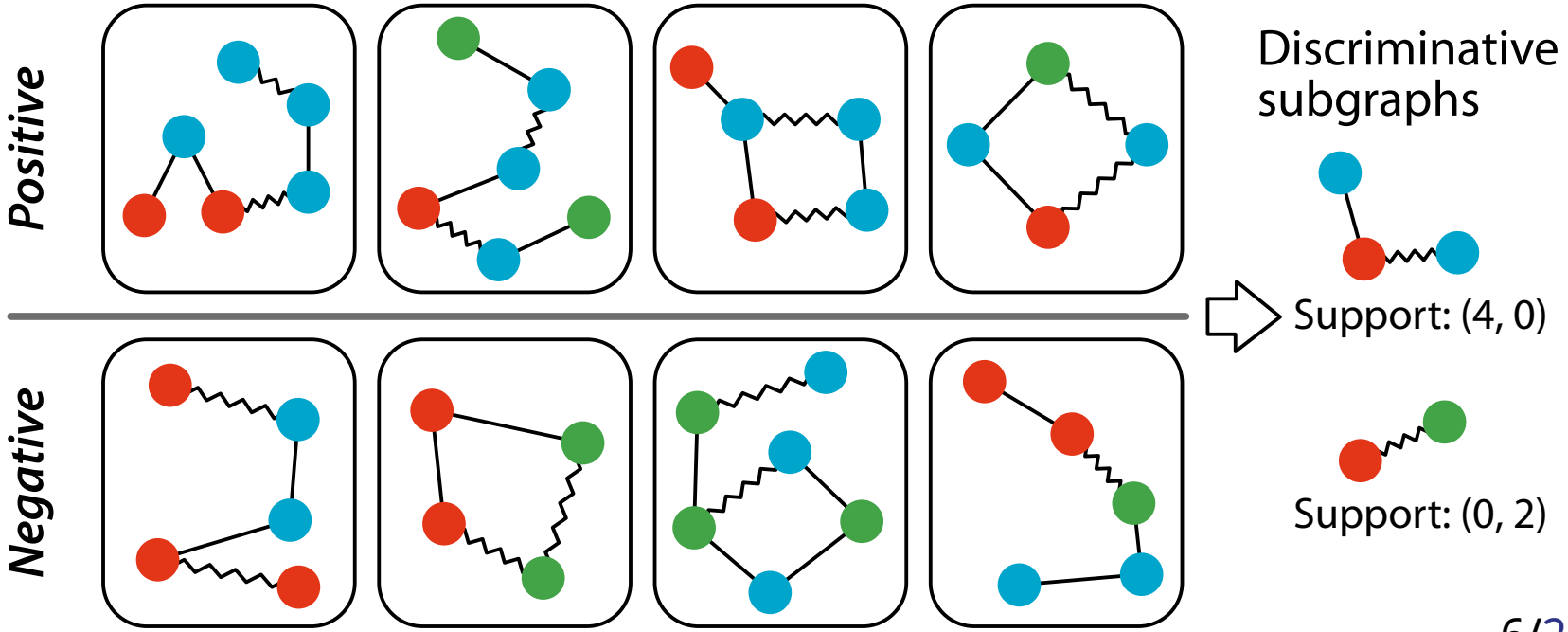
Supervised Itemset Mining

- Find discriminative patterns from supervised data



Supervised Subgraph Mining

- Find discriminative patterns from supervised data



Contingency Table

- Assume that the entire dataset D is divided into positives C and negatives $\overline{C}$ such that $C \cup \overline{C} = D$ and $C \cap \overline{C} = \emptyset$
- For each pattern x, we have the following contingency table:

	Occurrence	Non-occurrence	Total
Positive	$\text{supp}_C(x)$	$\lvert C\rvert - \text{supp}_C(x)$	$\lvert C\rvert$
Negative	$\text{supp}_{\overline{C}}(x)$	$\lvert \overline{C}\rvert - \text{supp}_{\overline{C}}(x)$	$\lvert \overline{C}\rvert$
Total	$\text{supp}(x)$	$\lvert D\rvert - \text{supp}(x)$	$\lvert D\rvert$

- $\text{supp}(x)$: the support of x and $\text{supp}(x) = \text{supp}_C(x) + \text{supp}_{\overline{C}}(x)$

Contingency Table

- Replace each cell with the following symbols for simplicity:

	Occurrence	Non-occurrence	Total
Positive	n_{11}	n_{12}	c_1
Negative	n_{21}	n_{22}	c_2
Total	s	s'	d

Various Measures

- Confidence: n_{11}/d
- Growth rate (relative risk): n_{11}/n_{21}
- Support difference (risk difference): $n_{11} - n_{21}$
- Mutual information:
  $$\frac{n_{11}}{d} \log \frac{n_{11}/d}{c_1 s/d^2} + \frac{n_{12}}{d} \log \frac{n_{12}/d}{c_1 s'/d^2} + \frac{n_{21}}{d} \log \frac{n_{21}/d}{c_2 s/d^2} + \frac{n_{22}}{d} \log \frac{n_{22}/d}{c_2 s'/d^2}$$
- Subgroup discovery measure (weighted relative accuracy):
  $(c_1/d)\,((n_{11}/c_1) - (c_1/d))$

Computing p-value of Patterns

- Given positive and negative sample sets $C, \overline{C}$ such that $D = C \cup \overline{C}$
- The p-value of each pattern x is assessed by the Fisher's exact test

	Occur.	Non-occur.	Total
Pos.	$\text{supp}_C(x)$	$\lvert C\rvert - \text{supp}_C(x)$	$\lvert C\rvert$
Neg.	$\text{supp}_{\overline{C}}(x)$	$\lvert \overline{C}\rvert - \text{supp}_{\overline{C}}(x)$	$\lvert \overline{C}\rvert$
Total	$\text{supp}(x)$	$\lvert D\rvert - \text{supp}(x)$	$\lvert D\rvert$

Computing *p*-value of Patterns

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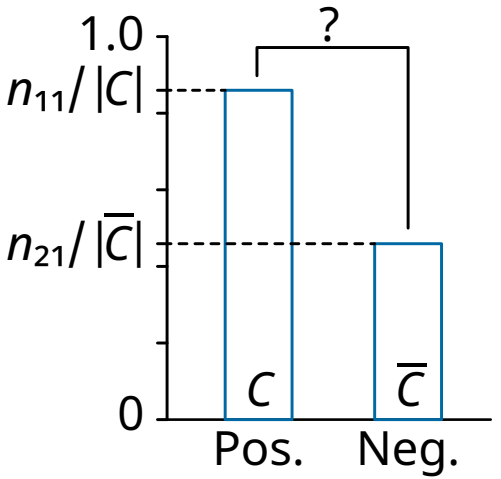
Pos.	n_{11}	n_{21}	$\lvert C \rvert$
Neg.	n_{21}	n_{22}	$\lvert \overline{C} \rvert$
Total	$\mathrm{supp}(x)$	$\lvert D \rvert - \mathrm{supp}(x)$	$\lvert D \rvert$

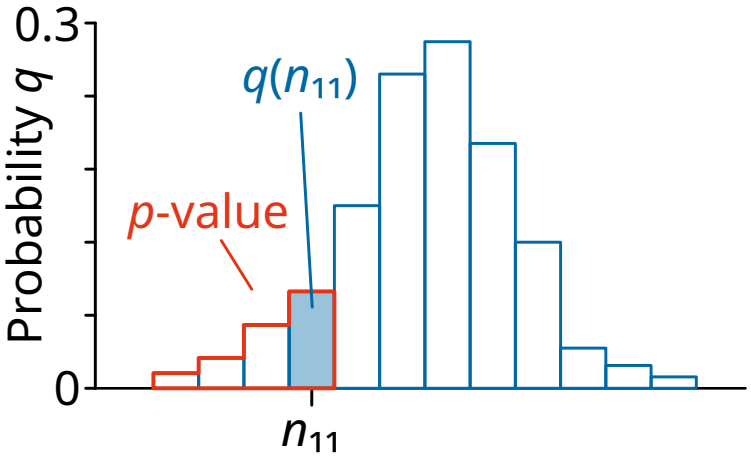


Fisher's Exact Test

- Probability $q(n_{11})$ is given by hypergeometric distribution:

$$q(n_{11}) = \binom{|C|}{n_{11}} \binom{|\overline{C}|}{n_{21}} \Big/ \binom{|D|}{\mathrm{supp}(s)}$$

	Occur.	Non-occur.	Total
Pos.	n_{11}	n_{21}	$\lvert C\rvert$
Neg.	n_{21}	n_{22}	$\lvert\overline{C}\rvert$
Total	$\mathrm{supp}(x)$	$\lvert D\rvert - \mathrm{supp}(x)$	$\lvert D\rvert$



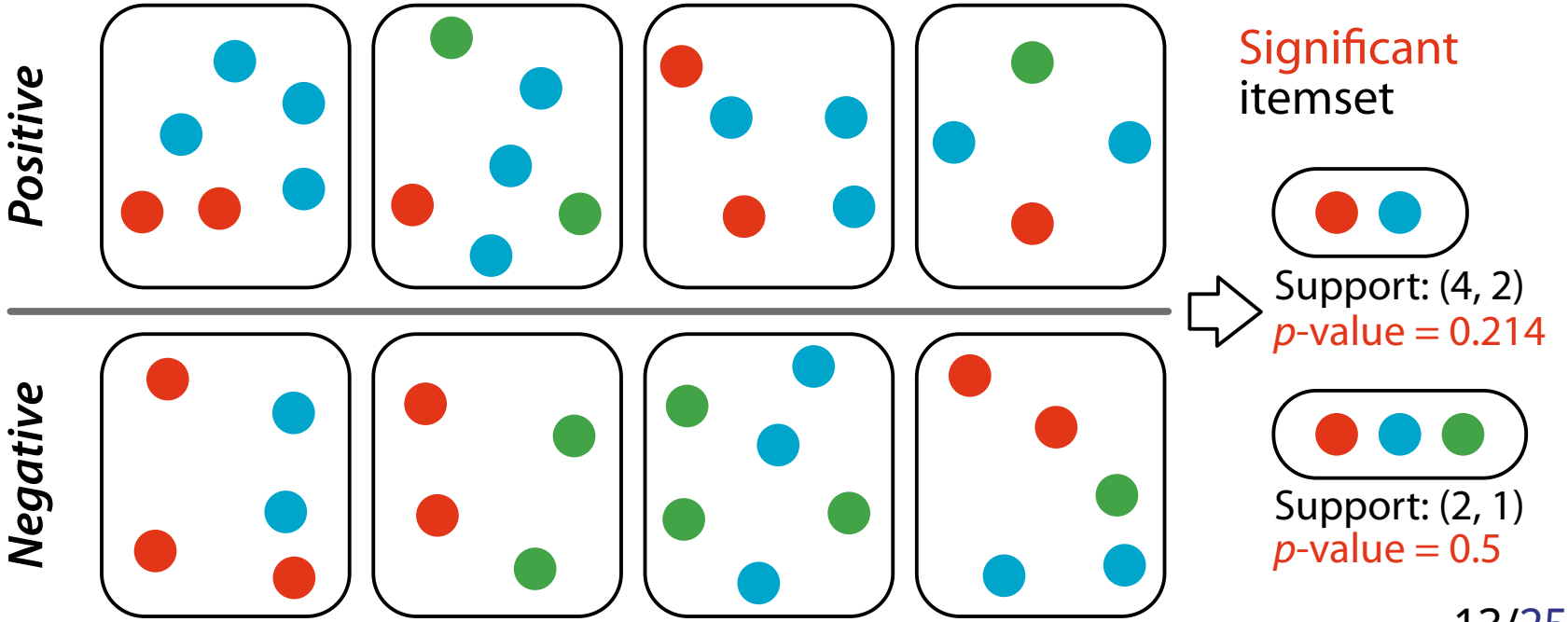
Hypothesis Test for Each Pattern

- **Null:** Occurrence of the pattern is independent from classes
- **Alternative:** Occurrence of the pattern is associated with classes

	Alternative hypothesis is true	Null hypothesis is true
Declared significant (p-value $< \alpha$)	True Positive	False Positive (Type I Error)
Declared non-significant	False Negative (Type II Error)	True Negative

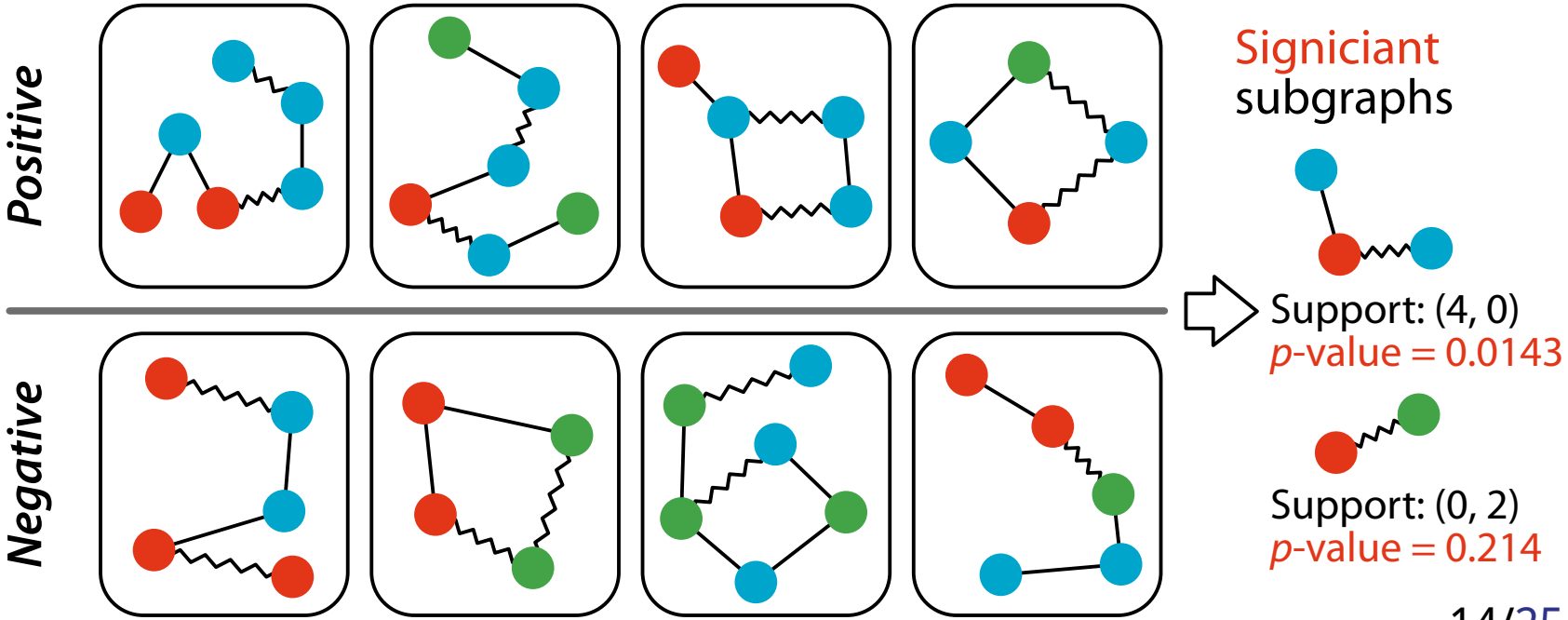
Significant Itemset Mining

- Find discriminative patterns from supervised data



Significant Subgraph Mining

- Find discriminative patterns from supervised data

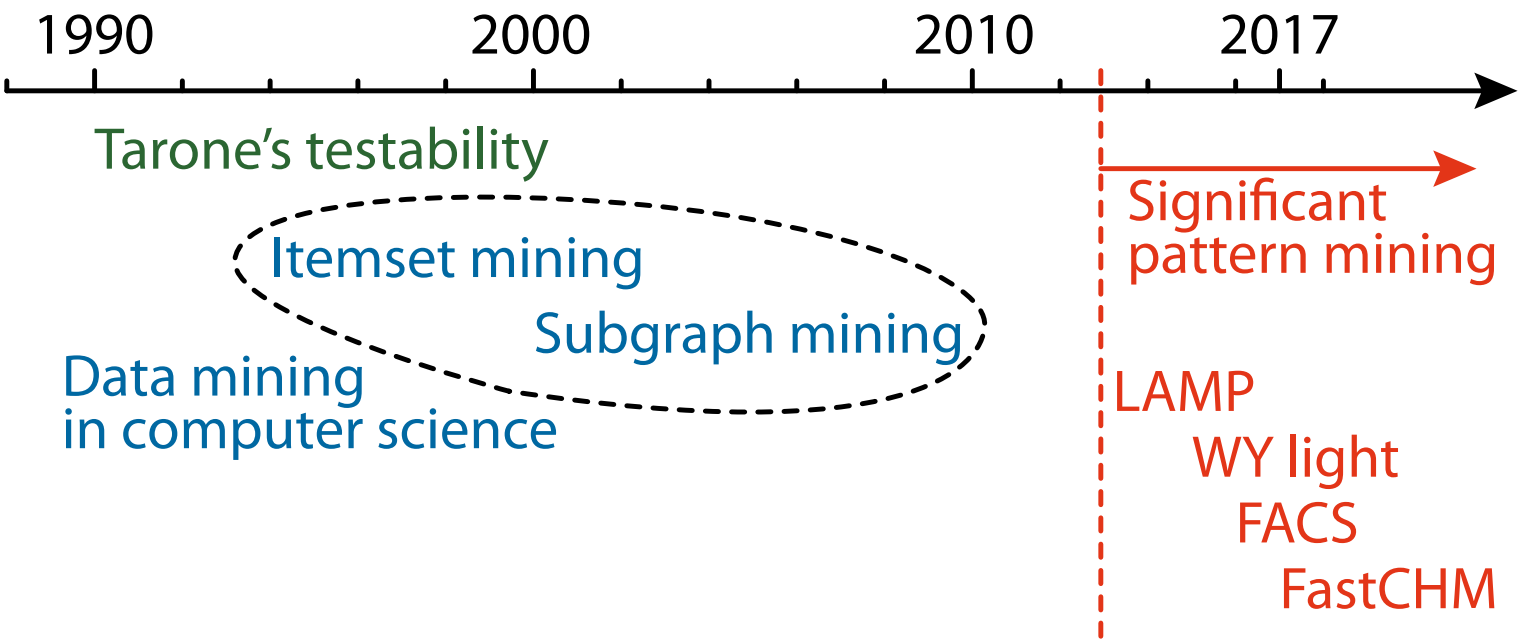


Challenges and Solutions

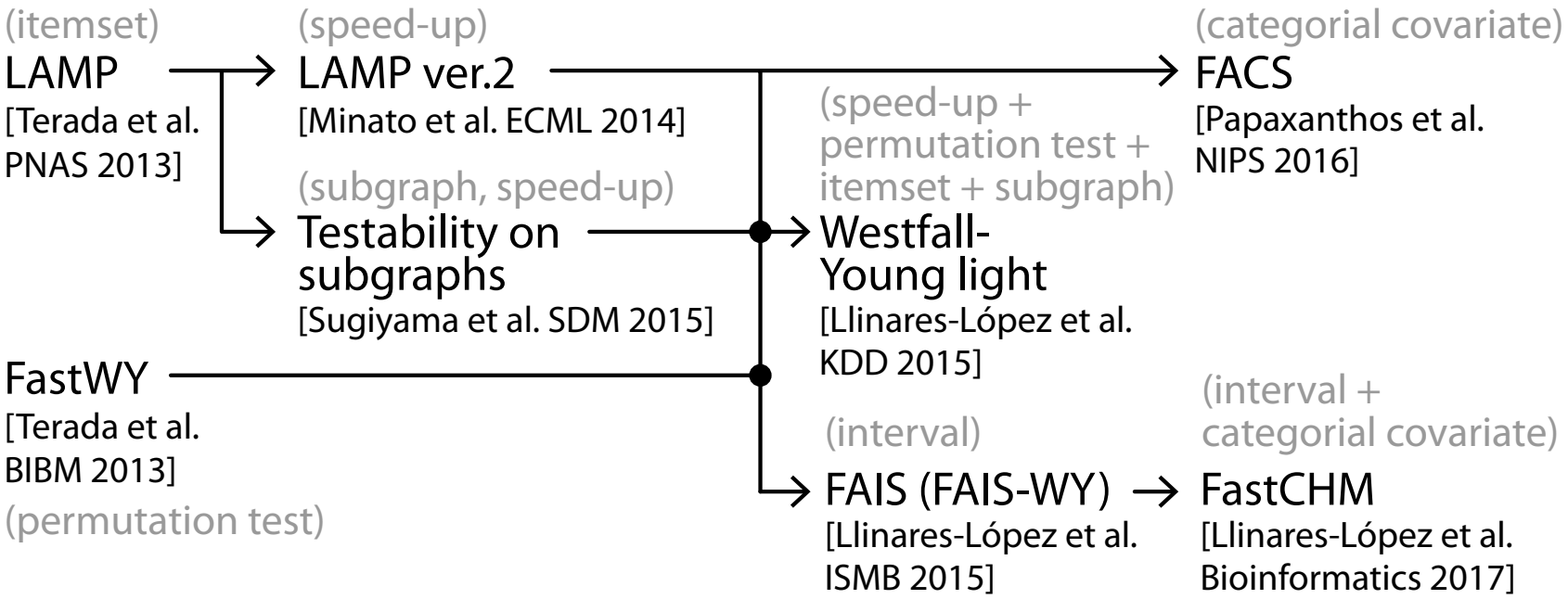
1. **Computational:** How to check all patterns with avoiding combinatorial explosion?
2. **Statistical:** How to measure the statistical association (i.e. p-value) with correcting for multiple testing with avoiding combinatorial explosion?

- **Answer: Tarone's trick + Apriori principle**
  - The Tarone's trick defines patterns that are irrelevant
  - The Apriori principle efficiently prunes such patterns using the partial order structure of patterns

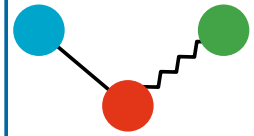
Timeline


1990
2000
2010
2017
Tarone's testability
Itemset mining
Subgraph mining
Data mining
in computer science
Significant
pattern mining
LAMP
WY light
FACS
FastCHM

Summary of SPM Methods



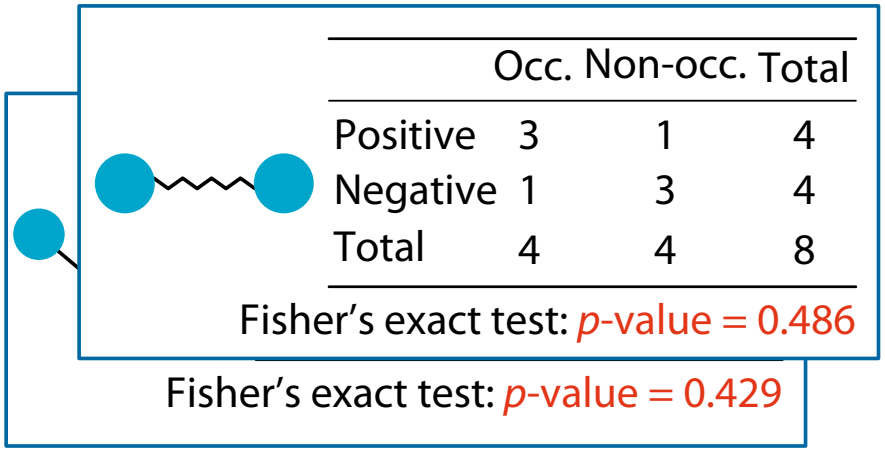
Multiple Testing



	Occ.	Non-occ.	Total
Positive	4	0	4
Negative	2	2	4
Total	6	2	8

Fisher's exact test: p-value = 0.429

Multiple Testing

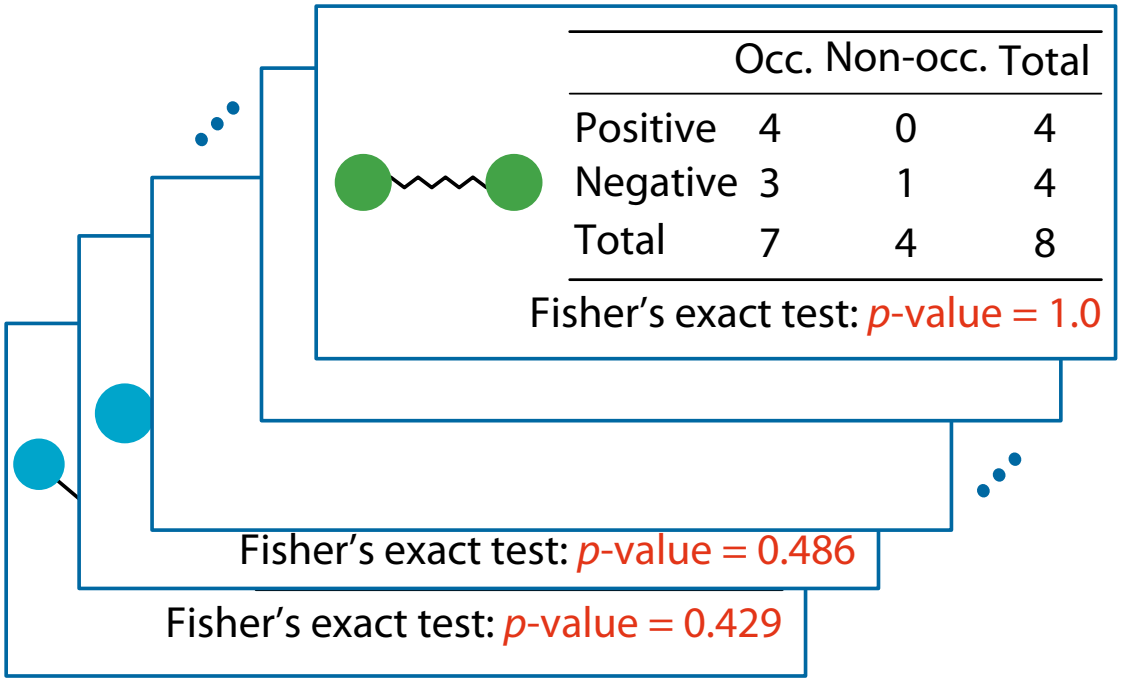


	Occ.	Non-occ.	Total
Positive	3	1	4
Negative	1	3	4
Total	4	4	8

Fisher's exact test: *p*-value = 0.486

Fisher's exact test: *p*-value = 0.429

Multiple Testing



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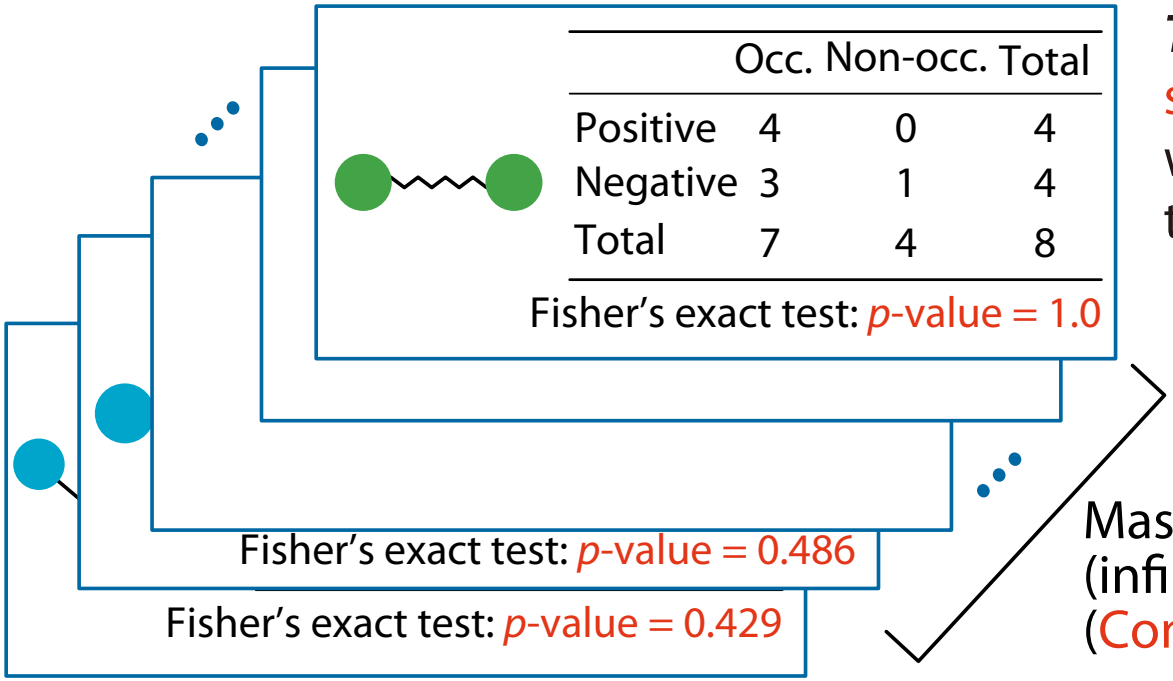

Task: Enumerate all significant patterns while controlling the FWER

Massive number of (infinitely many) patterns (Combinatorial explosion!)

Multiple Testing Correction

- In each test, [probability of having a false positive] $\leq \alpha$
- If we repeat m tests, αm patterns can be false positives
  - Too many if m is large! For example in itemset mining:
    - For 100000 items, #patterns $= 2^{100000}$
    - Set significance level $\alpha = 0.01$
    - Number of false positives: $0.01 \cdot 2^{100000} = 10^{30101}$

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    - For 100000 items, #patterns $= 2^{100000}$
    - Set significance level $\alpha = 0.01$
    - Number of false positives: $0.01 \cdot 2^{100000} = 10^{30101}$
- FWER (family-wise error rate): ***Probability of having more than one false positives among all patterns***
  - FWER $= 1 - (1 - \alpha)^m$ if patterns are independent

Controlling the FWER

- FWER $= \Pr(\mathrm{FP} > 0)$
  - FP: Number of false positives
- To achieve FWER $= \alpha$, we change the significance level for each pattern from α to δ ($\delta \leq \alpha$), the corrected significance level

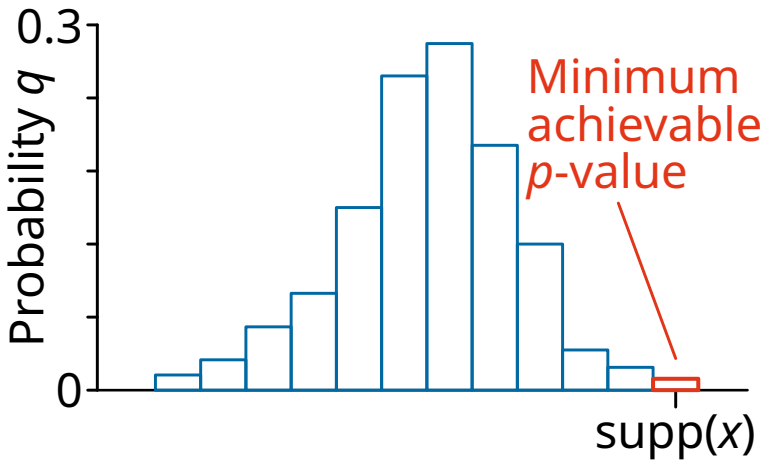
Controlling the FWER

- FWER $= \Pr(\mathrm{FP} > 0)$
  - FP: Number of false positives
- To achieve FWER $= \alpha$, we change the significance level for each pattern from α to δ ($\delta \leq \alpha$), the corrected significance level
- **Objective**: Maximize FWER(δ) subject to FWER(δ) $\leq \alpha$
  - FWER(δ): FWER at corrected significance level δ
    - Cannot be evaluated in closed form (simple but not easy!)
  - Bonferroni correction is popular: $\delta^*_{\mathrm{Bon}} = \alpha / m$

Minimum Achievable p-value $\Psi(\sigma)$

- Consider the minimum achievable p-value $\Psi(x)$ of a pattern x for its support $\mathrm{supp}(x)$

	Occur.	Non-occur.	Total
Pos.	$\mathrm{supp}(x)$	n_{21}	$\lvert C\rvert$
Neg.	0	n_{22}	$\lvert\overline{C}\rvert$
Total	$\mathrm{supp}(x)$	$\lvert D\rvert - \mathrm{supp}(x)$	$\lvert D\rvert$

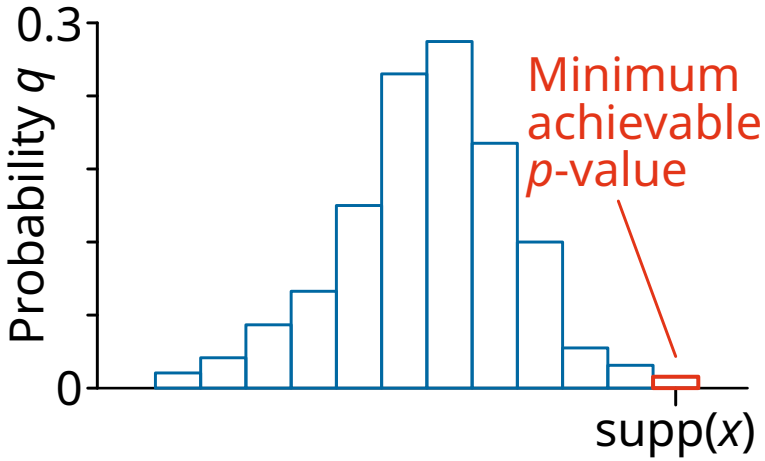


- Most biased case that achieves the minimum p-value

Computing $\Psi(x)$

Minimum achievable p-value: $\Psi(x) = \binom{|C|}{\mathrm{supp}(x)} \Big/ \binom{|D|}{\mathrm{supp}(x)}$

	Occur.	Non-occur.	Total
Pos.	$\mathrm{supp}(x)$	n_{21}	$\lvert C\rvert$
Neg.	0	n_{22}	$\lvert\overline{C}\rvert$
Total	$\mathrm{supp}(x)$	$\lvert D\rvert - \mathrm{supp}(x)$	$\lvert D\rvert$



- Most biased case that achieves the minimum p-value

Tarone's Testability Trick

$x_1, x_2, x_3, \ldots, x_{m-1}, x_m, x_{m+1}, \ldots, x_{2^d}$ $\quad (\ \psi(x_i) \leq \psi(x_{i+1})\ )$

Tarone's Testability Trick

$m\psi(x_m) < \alpha$ and $(m+1)\psi(x_{m+1}) \geq \alpha$

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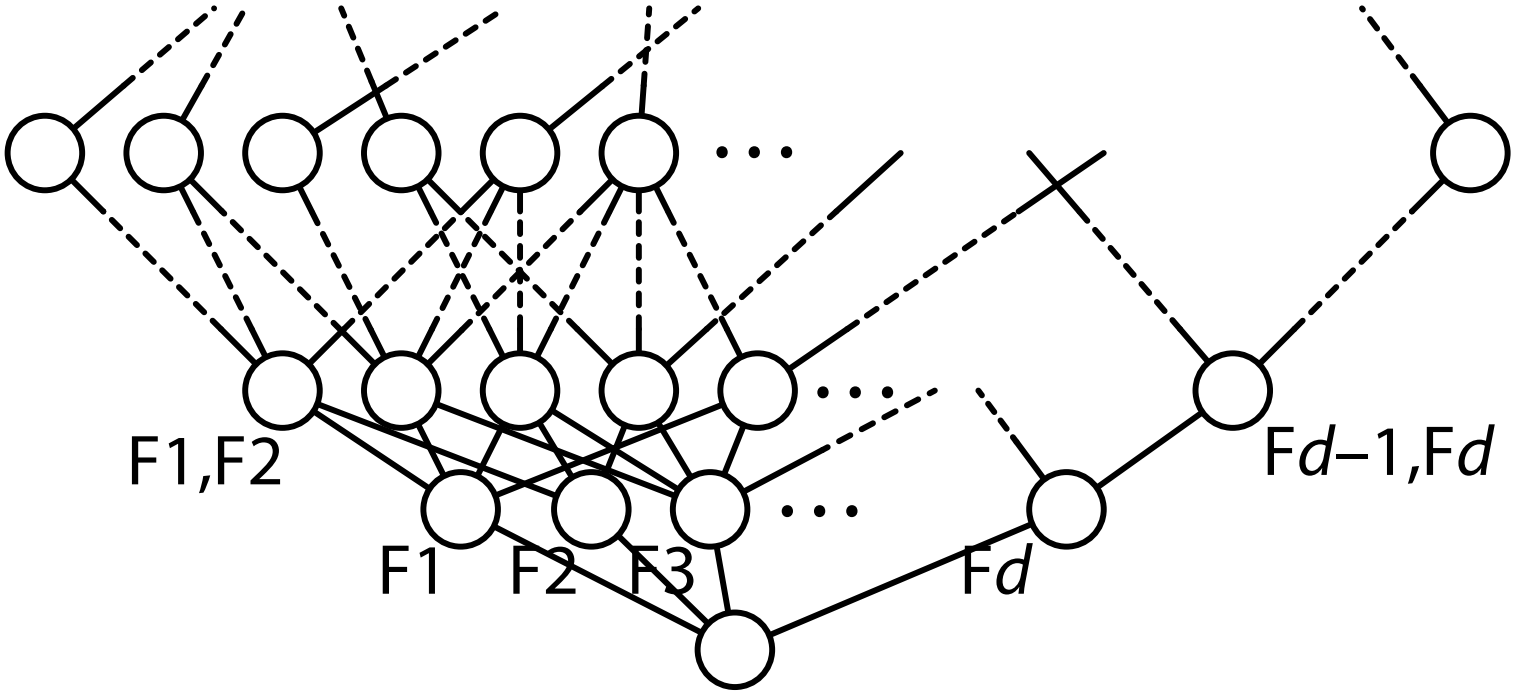
Testable patterns

Untestable patterns → Prune without testing

x_i is significant if: $p\text{-value}(x_i) < \alpha / m$ — Correction factor

Enumeration Algorithm Based on Apriori



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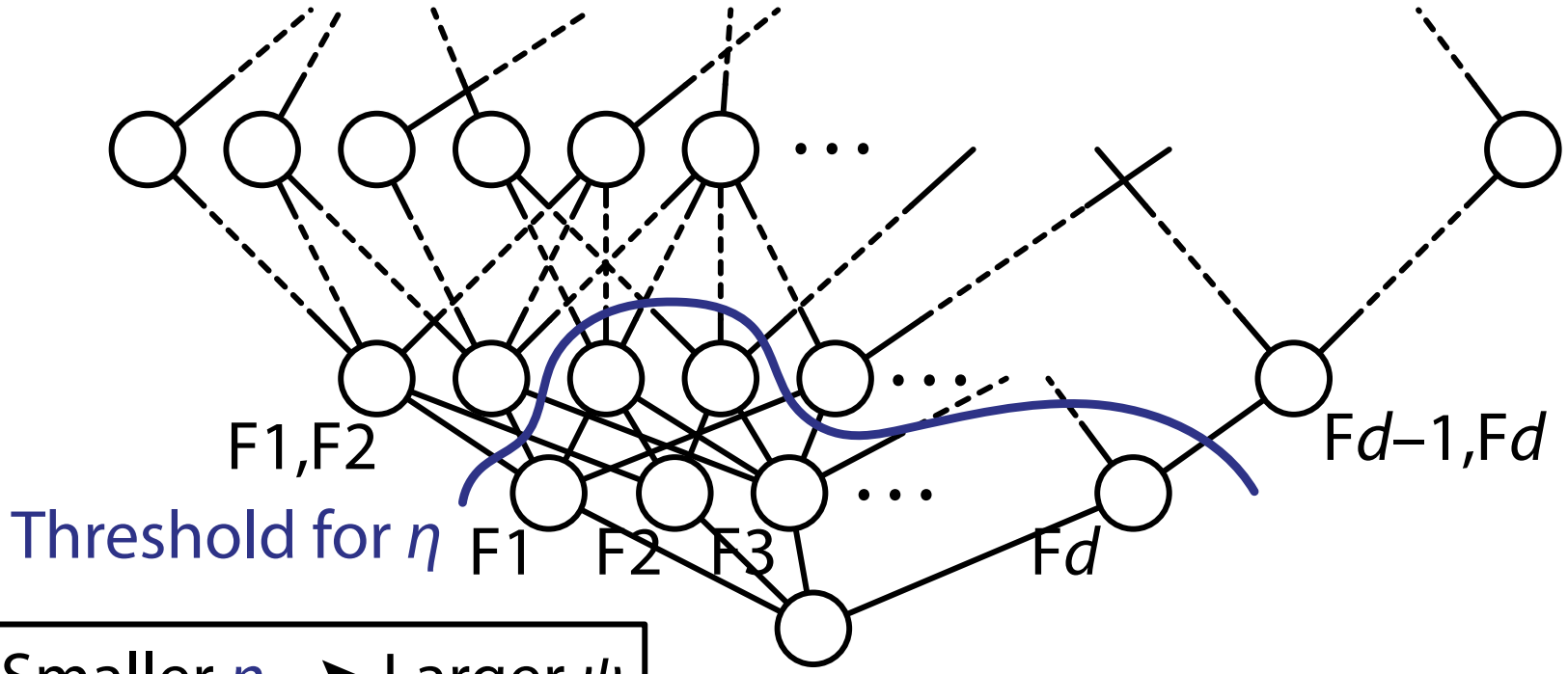
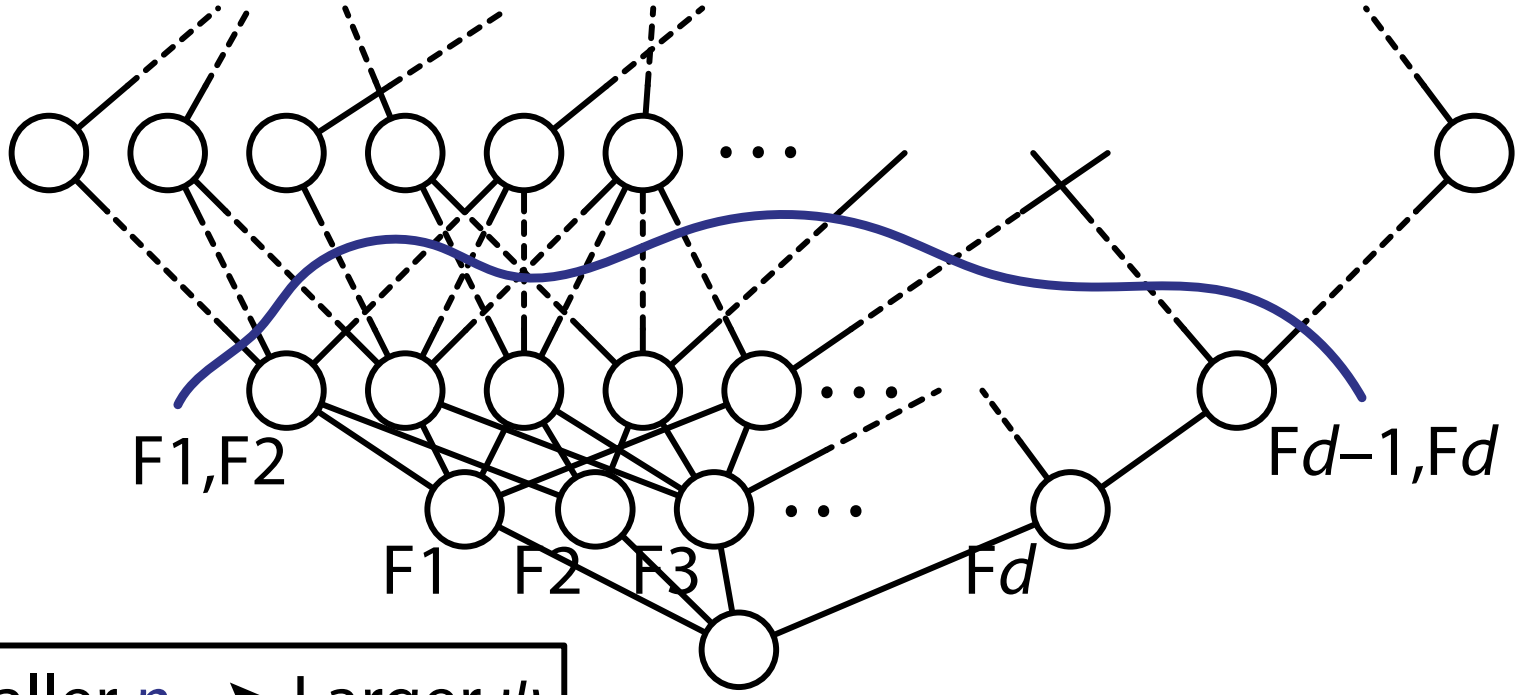


Smaller η → Larger ψ

Enumeration Algorithm Based on Apriori



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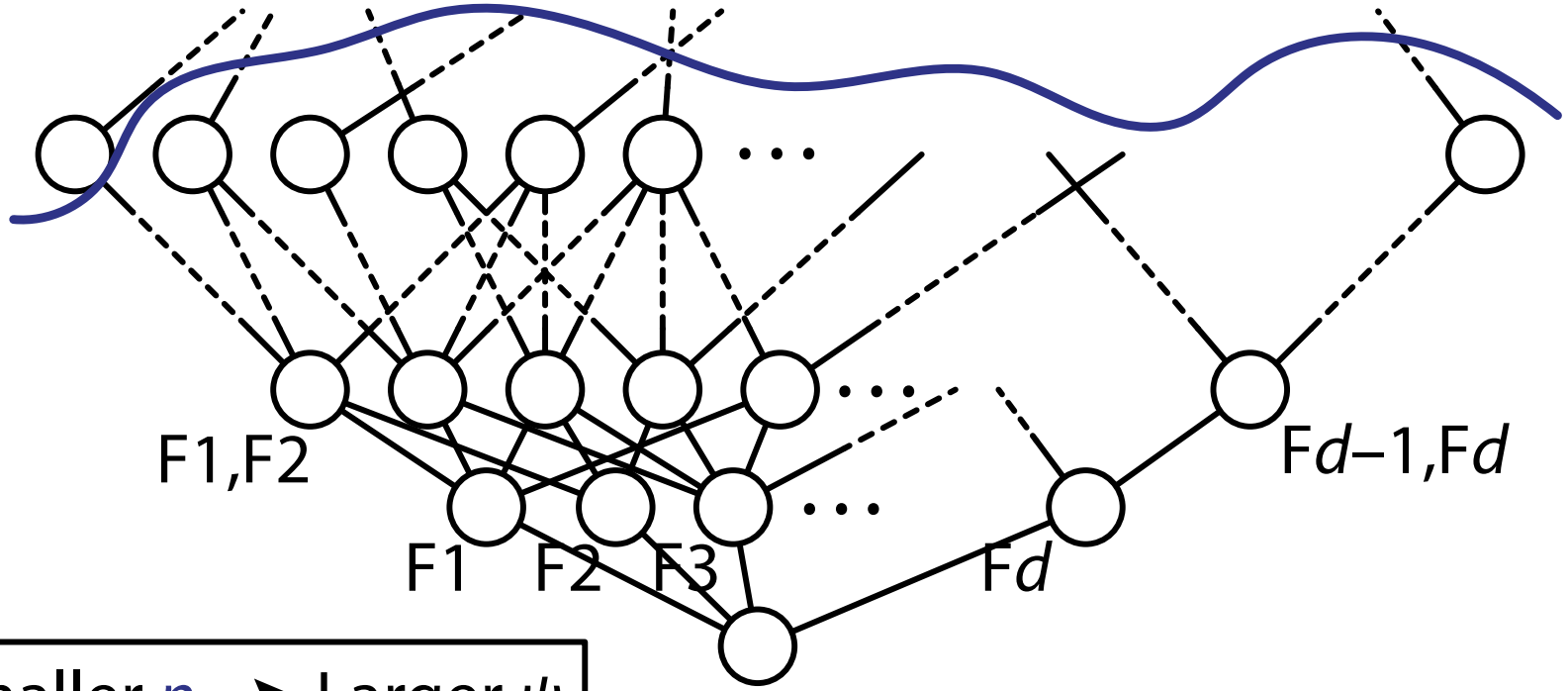
Enumeration Algorithm Based on Apriori



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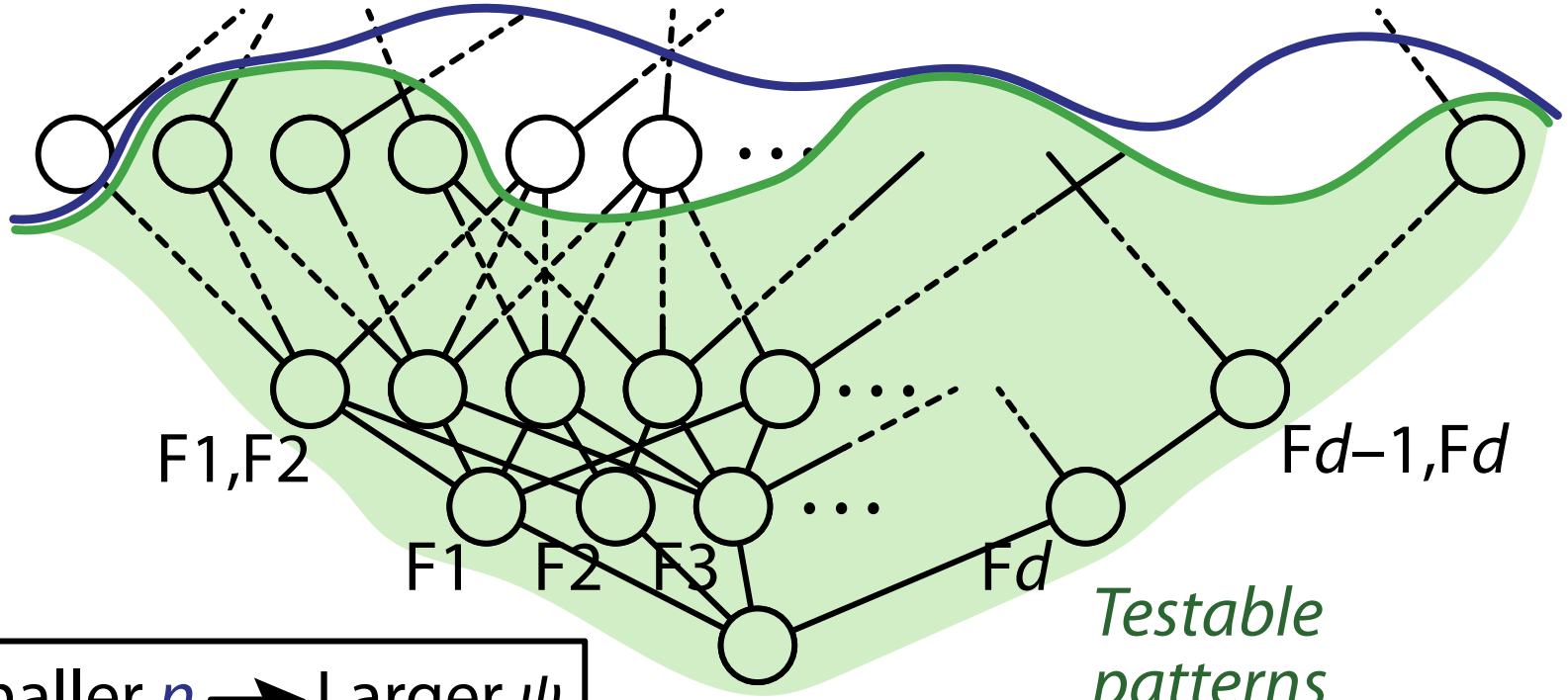
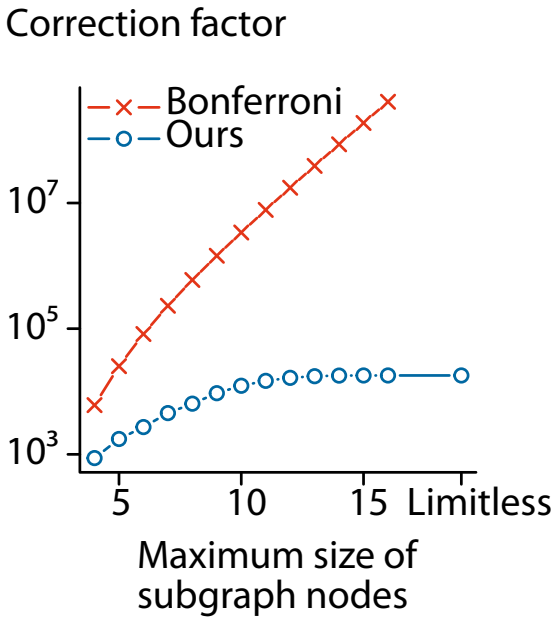
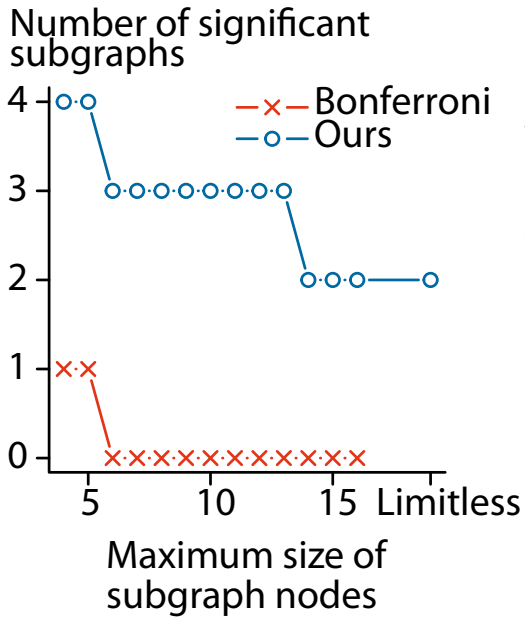
Enumeration Algorithm Based on Apriori

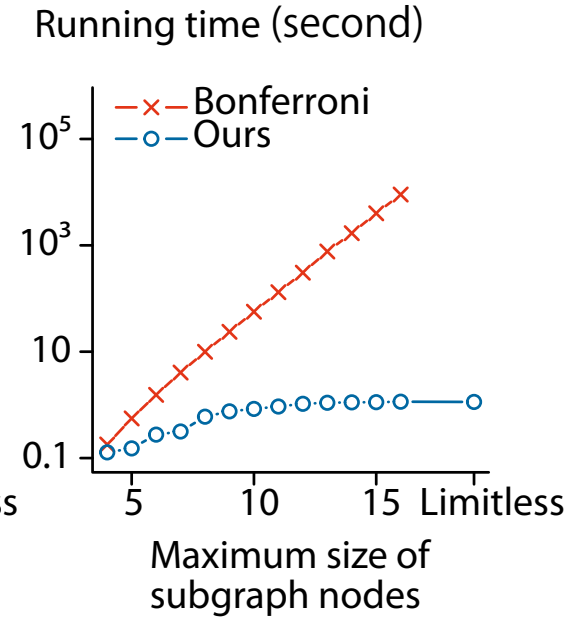


Smaller η → Larger ψ

Power of Testability (Subgraph Mining)







The PTC (Predictive Toxicology Challenge) dataset with 601 chemical compounds

Conclusion

- Supervised pattern mining has been considered
- Significant pattern mining is introduced
  - Find statistically significant patterns while controlling the FWER
  - pattern mining (data mining) + multiple testing correction (statistics)
  - Key technique: Tarone's trick